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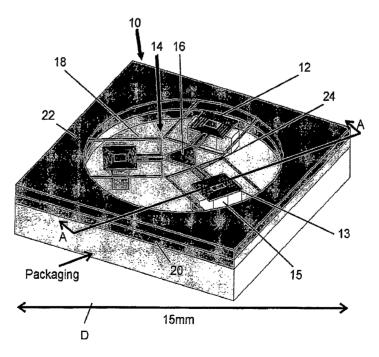
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[Continued on next page]

(54) Title: 6-AXIS ELECTROMAGNETICALLY-ACTUATED MESO-SCALE NANOPOSITIONER



(57) Abstract: A MEMS actuator includes a coil stack in the form of microf abricated, electrically conductive first and second superposed layers. A magnet: array is superposed in magnetic communication with the coil stack, with first and second coils being selectively, electrically actuatable to generate relative movement between the coil stack and the magnet array both in-plane and out-of -plane. In various embodiments, a plurality of the actuators are integrally coupled to a microf abricated compliant mechanism to provide a high bandwidth, six degree of freedom nanopositioner.



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6-Axis Electromagnetically-Actuated Meso-Scale Nanopositioner

BACKGROUND

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Related Application

This application claims the benefit of U.S. 10 Provisional Application Ser. No. 60/777,252, entitled 6-Axis Electromagnetically-Actuated Meso-Scale Nanopositioner, filed on 02/27/2006, the contents of which are incorporated herein by reference in their entirety for all purposes. This application is a Continuation-In-Part of U.S. Patent Application Ser. No. 15 11/037,866, filed on 01/18/2005, entitled Multiple Degree of Freedom Micro Electro-Mechanical System Positioner and Actuator. This application is also related to U.S. Patent No. 7,093,827, filed on 06/19/2002, entitled 20 Multiple Degree Of Freedom Compliant Mechanism, the contents of which are incorporated herein by reference in their entirety for all purposes.

1. Technical Field

This invention relates to MEMS devices, and more

particularly to a microfabricated nanopositioner capable of movement in six degrees of freedom.

2. Background Information

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Throughout this application, various publications, patents and published patent applications are referred to by an identifying citation. The disclosures of the publications, patents and published patent applications referenced in this application are hereby incorporated by reference into the present disclosure.

A wide variety of micro-fabricated nanopositioners are known in the art. These devices are operated by a variety of actuation species, including electrostatic, electromagnetic, electrothermal, and piezoelectric.

These nanopositioners are motion systems capable of
positioning a sample in space with nanometer precision
(e.g., within tens of nanometers). Nanopositioners can
operate in multiple axes, to provide accurate orientation
in many degrees-of-freedom (DOF). Multi-axis meso-scale
(e.g., 5 to tens of millimeter- or coin-sized)
nanopositioners may enable high-speed and precise

positioning and measurement in the biological sciences, data storage, probing equipment for nano-scale measurements, and nanomanufacturing processes. Emerging applications in these fields would benefit from portable, multi-axis, nanometer-level positioning over a range of tens-of-microns at speeds of hundreds to thousands of Hertz.

Relatively large, macro-scale nanopositioners can position large and small objects over a range of hundreds of microns with nanometer precision in up to six degrees-of-freedom, but their relatively large masses limit their natural frequencies to 10-100 Hz. Many of these devices

operate under closed loop control, require high-voltage power supplies, and often cost thousands of dollars. In addition, thermal fluctuations can generate relatively large position errors in macro-scale machines. The positioning of small-scale samples, such as probe tips, cells, thin-film samples, and micro-optics, often does not require the force and stroke capabilities of these large nanopositioners.

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The mismatch between the length/time scales (i.e., range of motion and speed of movement) of macro-scale 10 positioners and many nano-scale phenomena limits the use of these nanopositioners in future small-scale applications. For instance, nano-scale electro-machining is a serial process requiring as little as several hundreds of microseconds to remove cubic-nanometers of material. 15 Sample moves of several microns should be executed in milliseconds and with nanometer precision in order to make the nano-machining process practical and time efficient. As another example, probe-based data storage may also benefit from millisecond move times and nanometer precision 20 in order to improve data rates and storage density.

However, such small scale nanopositioners have not been previously developed. Although much of the physics scale from macro- to micro-scale systems, microfabrication constraints fundamentally change the design methodology for small-scale nanopositioners. Assembly and fabrication methods used to realize macro-scale electromagnetic (EM) actuators are generally unsuitable for building micro- and meso-scale (i.e., microfabricated) actuators.

Contrary to the conventional approaches used to fabricate macro-scale actuators, microfabricated micro-coil structures are limited to generally planar geometries. For

example, a planar EM actuator is disclosed in U.S. Patent No. 6,369,400 (the '400 patent). This patent discloses a magnetic scanning or positioning system fabricated using conventional microlithographic techniques. The system includes a base equipped with magnets, a movable platform 5 equipped with electrical coils, and suspension elements providing an elastic connection between the movable platform and the supporting base. The electrical coils are positioned flat on the movable platform, to form a substantially flat arrangement with the movable platform. 10 The `400 patent teaches that combining the flat arrangement with the flat supporting base yields a scanning or positioning system which is potentially compact, lightweight and flat and which features fast response, low power consumption and a relatively wide range of motion, 15 e.g., between 1 μm and 10 mm. The device is taught to be useful in the field of scanning probe microscopy or in the field of data storage or imaging.

A drawback, however, of this approach is that the

coils are rigidly coupled to the movable stage, which
results in a relatively large moving mass. This large mass
and its associated low resonance frequency, results in a
relatively low bandwidth, i.e., slow response time. This
configuration also results in a relatively large footprint,

which tends to undesirably limit component density. In
addition, the system as shown is limited to motion in 5 DOF
(not 6), and suffers from a relatively complex fabrication
process.

Realizing six DOF, open-loop positioning, with precision to within tens of nanometers at speeds of hundreds to a thousand Hz or more will require a departure from the traditional micro-scale and macro-scale EM

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actuator design.

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In light of the foregoing, a need exists for a mesoscale, multi-axis nanopositioning system capable of operating at hundreds of Hz to kilohertz frequencies with tens-of-microns of stroke, and nanometer level precision.

Summary

In one aspect of the invention, an electromagnetically actuated microfabricated nanopositioner includes a compliant mechanism and a plurality of microfabricated The compliant mechanism includes a stage, a actuators. support, a plurality of flexures coupled to the stage and to the support, and a plurality of beams each coupled to one of the flexures. The beams are sized and shaped so that their displacement generates a displacement of the stage relative to the support. The actuators are coupled to the beams, each actuator including a coil stack of first and second coils in the form of electrically conductive superposed layers extending parallel to the compliant mechanism. A magnet array is disposed in magnetic communication with the coil stack. The coils are each selectively, electrically actuatable to generate relative movement between the coil stack and the magnet array both in-plane and out-of-plane, so that the stage is configured for controlled movement with 6 degrees of freedom.

In another aspect of the invention, a MEMS actuator includes a coil stack of first and second coils in the form of microfabricated, electrically conductive first and second superposed layers. A magnet array is superposed in magnetic communication with the coil stack. The first and second coils are selectively, electrically actuatable to

generate relative movement between the coil stack and the magnet array both in-plane and out-of-plane.

In yet another aspect of the invention, a method is provided for effecting a MEMS actuation. The method includes providing at least one actuator having first and second coils in the form of microfabricated, electrically conductive first and second superposed layers, and a magnet array superposed, in magnetic communication, with the coils. The method further includes selectively, electrically actuating the first and second coils to generate relative movement between the coil stack and the magnet array both in-plane and out-of-plane.

BRIEF DESCRIPTION OF THE DRAWINGS

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The above and other features and advantages of this invention will be more readily apparent from a reading of the following detailed description of various aspects of the invention taken in conjunction with the accompanying drawings.

Fig. 1 is perspective view of an exemplary embodiment of a nanopositioner of the present invention;

Fig. 2 is a graphical representation of the natural frequencies of moving coil versus moving magnet actuators of the present invention;

Fig. 3A is a perspective view of an exemplary moving coil actuator used in the embodiment of Fig. 1;

Fig. 3B is a cross-sectional schematic view of the actuator of Fig. 3A, taken along A-A of Fig. 1, showing stacked X- and Z- coils suspended above a fixed 3-pole permanent magnet array;

Fig. 3C is a schematic plan view of the Z- actuator coil of Fig. 3B;

Fig. 3D is a schematic plan view of the X- actuator coils of Fig. 3B;

Figs. 4A and 4B are graphical representations of actuation force and moment calculations versus geometric parameter ratio d/a for the exemplary coils of Figs. 3A-3D;

Fig. 5A is a perspective schematic representation of portions of the actuator of Fig. 3A;

Fig. 5B is a schematic view taken along 5B-5B of Fig. 5A;

Figs. 6-8 are schematic views of exemplary systems into which the embodiment of Fig. 2 may be incorporated; and

Fig. 9 is a series of schematic cross-sections taken along A-A of Fig. 1, at various steps in a representative fabrication of an embodiment of the present invention.

20 DETAILED DESCRIPTION

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In the following detailed description, reference is made to the accompanying drawings that form a part hereof, and in which is shown by way of illustration,

25 specific embodiments in which the invention may be practiced. These embodiments are described in sufficient detail to enable those skilled in the art to practice the invention, and it is to be understood that other embodiments may be utilized. It is also to be understood that structural, procedural and system changes may be made without departing from the spirit and scope of the present invention. The following detailed description is,

therefore, not to be taken in a limiting sense, and the scope of the present invention is defined by the appended claims and their equivalents. For clarity of exposition, like features shown in the accompanying drawings are indicated with like reference numerals and similar features as shown in alternate embodiments in the drawings are indicated with similar reference numerals.

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As shown in Fig. 1, embodiments of the present invention include a micro-electromagnetically actuated, meso-scale, high speed, microlithographic nanopositioning system that operates with nanometer (e.g., within tens of nanometers) precision in multiple axes. These embodiments thus include a MEMS (Micro Electro-Mechanical System) nanopositioner 10 having a series of actuators 12 in the form of stacked microfabricated coils (coil stack) 13 and magnet arrays 15. These actuators are coupled to a microfabricated compliant mechanism 14 (including a stage 16 supported by a plurality of flexures 18) of the type disclosed in U.S. Patent No. 7,093,827 entitled Multiple Degree Of Freedom Compliant Mechanism (the '827 patent), which is fully incorporated by reference herein.

The actuators 12, while being substantially planar, are capable of both in-plane and out-of-plane movement. When coupled to the compliant mechanism 14, the result is a nanopositioner 10 that is easily fabricated on a small scale (e.g., 15mm to 30mm or less) using conventional microfabrication (e.g., micro-lithographic) techniques, and which is capable of generating controlled movement with nanometer precision in a full 6 degrees of freedom.

These embodiments include a relatively low moving mass, by decoupling much of the movement of the coils from that of the central stage, as discussed in greater detail

hereinbelow. This aspect, in combination with the optional moving-coil configuration also discussed below, tends to provide various embodiments with a relatively high resonance frequency, and concomitantly, high bandwidth (i.e., high speed) response times. Embodiments of the invention also provide convenient compensation for any thermal errors and/or actuator torque.

As mentioned, embodiments may be provided with either a moving-coil or a moving-magnet configuration. instances, control is achieved by energizing the coil 10 structure. Moving-magnet actuators may benefit from minimal heat generation on the moving stage 16, since the coil structure (which generates heat) is mechanically (and thus substantially thermally) isolated from the stage. However, moving-magnet systems employ a larger sprung mass 15 than similarly sized moving-coil systems, which provides the moving-magnet system with a lower natural frequency. This may be seen in Fig. 2, in which the extra sprung mass of an exemplary one DOF moving-magnet actuator has a natural frequency that is substantially lower than a 20 similar moving-coil actuator.

Many embodiments of the present invention thus may benefit from using a moving-coil configuration. However, it has been found that coil heat dissipation may affect precision and repeatability. Thermal simulation of various configurations has indicated that the resulting out-of-plane position error from heating may be as high as about 1000nm if not compensated. Embodiments of the present invention thus provide thermal error correction capabilities that may reduce these errors to less than 25nm, as discussed in greater detail hereinbelow. When so corrected, the dynamic benefit of these moving-coil

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embodiments tends to outweigh the loss in precision for many applications. In addition, relatively difficult assembly of millimeter-sized magnets onto delicate microfabricated flexures may be advantageously avoided by use of moving-coil configurations.

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Turning back to Fig. 1, a representative embodiment of multi-axis nano-positioner 10 of the present invention is described in greater detail. This embodiment includes multi-level planar micro-coil stacks 13 fabricated onto planar compliant mechanism 14. A support (ground) portion 22 of the coil/mechanism combination is then bonded to a spacer 20 which includes a meso-scale array 15 of permanent magnets that creates an external magnetic field. As mentioned above, mechanism 14 is a six-axis (i.e., six DOF) spatial compliant flexure such as disclosed in the '827 patent.

Compliant mechanism 14 is a microfabricated (e.g., microlithographic) device including stage 16, a support 22, and a series of flexures 18 coupled to the support and to the stage (e.g., via beams 24 and paddles 26). The beams 24 are sized and shaped so that displacement thereof generates a displacement of the stage relative to the support. This beam/flexure configuration also provides a mechanical advantage which effectively decouples much of the movement of coils 28, 30 from stage 16. Such decoupling, in combination with the fixed-magnet/moving-coil, provides these embodiments with a relatively small moving mass and large bandwidth.

Turning now to Figs. 3A-3B, each actuator 12 includes
30 a first coil (e.g., x-actuator coil) 28 in the form of a
microfabricated, electrically conductive first layer, and
at least one second coil (e.g., z-actuator coil) 30 in the

form of a microfabricated electrically conductive second layer superposed with first coil 28 to form coil stack 13. Magnet array 15 is disposed in magnetic communication with coil stack 13 as shown. The first and second coils 28, 30 are selectively, electrically actuatable to generate relative movement between the coil stack 13 and magnet array 15 both in-plane (e.g., in the X-Y plane as shown) and out-of-plane (e.g., in the X-Z plane as shown), so that stage 16 is configured for controlled movement with 6 degrees of freedom.

Referring now to Figs. 3B-3D, operation of actuators 12 will now be described. As independent control currents Ix and Iz from a suitable power supply (not shown) flow through each coil 28, 30, a Lorentz force F acts on each coil, which is generally orthogonal to the magnetic flux lines 32 passing therethrough. This force F is described by the following Equation 1:

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$$F = \int_{S} I ds \times B$$
 Eq. 1

in which I is the current flowing through the coil, S is the total length of the coil, and B is the magnetic flux density (e.g., in air) generated by the magnet array 15.

Equation 1 holds for small coil sections, and low current densities relative to the equivalent current density of the permanent magnet. Embodiments of the present invention employ this phenomenon by choosing the phases and spacing of coils 28 and 30 relative to the magnet assembly so that the net resultant coil forces are predominantly in the X-and Z-directions, respectively.

For example, as shown in Figs. 3B and 3C, upper coil 30 is centered on the center magnet of array 15, with

magnetic flux lines 32 passing substantially along the X axis (e.g., horizontally in the orientation shown) through the coil. As such, current Iz (Fig. 3C) through coil 30 generates predominantly out-of-plane Z-forces (Fz, as shown).

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Referring to Figs. 3B and 3D, two coils 28 are disposed side-by-side, with the set being centered on the magnets of array 15. The coils 28 are close enough to magnet array 15 so that flux lines 32 are oriented predominantly on the Z axis as they pass therethrough. Current Ix through both of the coils thus generates predominantly in-plane, X-forces (Fx, Fig. 3B).

Although the aforementioned construction provides coil
28 with predominantly in-plane forces, it should be
15 recognized that flux lines 32 will not be purely Zdirected. Rather, as they pass through coils 28, flux
lines 32 will have some non-Z (e.g., X-directed) component,
due to the slight curvature of the flux as it passes
through the coil. This X-component will generate some Z20 directed forces on coils 28, to generate a net force that
is angled slightly out of plane (out of the X-Y plane as
shown). This may create a parasitic moment tending to
rotate the actuator about the Y-axis, which, in some
applications, may lead to parasitic positioning errors.

In various embodiments of the present invention, such parasitic moments may be compensated by use of multiple actuators, such as in the three-actuator arrangement shown in Fig. 1. In addition, and/or alternatively, any parasitic moments may be substantially eliminated by careful selection of coil geometries relative to the dimension of magnet array 15. For example, as shown in Figs. 3C and 3D, the geometric parameters d, a, and w

associated with coil 28, as described in Table 1 below, may be adjusted for torque cancellation.

5 Table 1. Actuator geometric parameters

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Parameter	Description
a	X and Y dimensions of the individual magnets of array 15
d	(d_z, d_x) gap distance between adjacent coil segments carrying current in the positive and negative y-directions
W	(w_z, w_x) Overall width of y-directed coil segments carrying current in same direction
i	(i_z, i_x) : electrical current in the coils

Moment cancellation in coil 28 (x-actuator) may be achieved by (1) setting w, a, i, coil spacing (of any adjacent coils 28), and coil height (Z distance above magnet array 15, Fig. 3B) to obtain the desired force; and (2) computing the forces and moments generated by various values of ratio d/a.

Referring to Figs. 4A and 4B, forces and moments of
exemplary x- and z-actuator coils 28, 30, are plotted
versus d/a ratio for a typical geometry with magnet
dimension a = 1mm. Fig. 4A indicates that the parasitic ydirected moment due to the pair of x-actuator coils 28 of
Fig. 3D is eliminated when the ratio d/a ~ 0.146. As
shown, moment cancellation occurs for this geometry because
the out-of-plane forces acting on the coil segments are
nominally balanced. It is also noted that the x-actuator
force is near maximum for the moment-compensating value of
d/a.

Similarly, the z-actuator coil 30 may be configured for maximum force by properly selecting ratio d/a. As shown, Fig. 4B indicates that the maximum out-of-plane

force for an example actuator occurs when $d/a \sim 0.55$. The maximum z-force is obtained when the y-directed coil segments (Fig. 3C) are in regions where the x-component of the magnetic flux density is greatest, i.e., above the interface between magnets of array 15 (Fig. 3B). It should be noted that the optimum geometric ratios for maximum force and parasitic moment minimization will change with the parameter w, the winding spacing, and the coil height above the magnet arrays.

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Turning now to Figs. 5A, 5B, in various embodiments, flexures 18 may also be configured to compensate for thermal error in the out-of-plane (z) direction. This error is due to bimetallic bending of the copper-on-silicon flexures. For clarity, actuator paddle 26, flexures 18, and support (ground) 22 are shown schematically in these figures.

In use, as the coils 28, 30 (Figs. 3B-3D) are energized to move the stage away from a neutral position, power is dissipated through resistive heating of the coil windings and lead traces. The heat is conducted away from 20 the coils 28, 30 through the flexures 18, which as best shown in Fig. 5B, may be fabricated from a semiconductor base (e.g., silicon) 32, which supports electrical conductors (e.g., copper leads) 34 thereon, with an insulator 36 (e.g., a thin layer of silicon dioxide) 25 therebetween. Differential thermal expansion between the copper 34 and silicon 32 induces bending of the flexure bearings which may lead to out-of-plane parasitic thermal error motion of several hundreds of nanometers at stage 16 30 (Fig. 1) in some embodiments.

In order to eliminate the thermal error motions, the temperature distribution along the flexure 18 from the

actuator paddle 26 to ground 22 may be computed using a simplified conductive heat transfer model along the flexure, as shown in the following Equation 2:

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$$T(x_b) = \frac{-q}{2k_{eq}}x_b^2 + \left(\frac{qL_{tot}}{k_{eq}} + \frac{P}{A_{eq}k_{eq}}\right)x_b + T_o.$$
 Eq. 2

which may be used to calculate the bending curvature along the flexure 18 from the paddle 26 to the ground 22. Based on well-known equations that govern thermomechanical bending of beams due to differential thermal expansion, the relative lengths (L1, L2, L3, and L4 in Fig. 5A) of the flexures 18 may be configured so that the out-of-plane thermal error is nominally eliminated. Moreover, this thermal error correction may be effected at nominally any level of current expected to be input into the actuator coils.

It should be noted that length L4 is the distance from the centerline of beam 24 to point at which flexure 18 engages actuator paddle 26.

Turning now to Figs. 6-8, embodiments of nanopositioner 10 may be used in nominally any application in which high speed positioning with controlled precision to within tens of nanometers or less is required. Such applications may include, for example, nano-electro machining systems 40 as shown schematically in Fig. 6, nano-manipulators such as the cellular micro-injection workstation 42 of Fig. 7, and data storage systems 44 such as shown in Fig. 8.

For example, a nanopositioner 10 provided with a transverse dimension D (Fig. 1) of about 20mm, may provide a natural frequency (bandwidth) of about 1kHz, a stroke of 10µm, positional precision within about 10nm, and a power

requirement of about 300mWatts or less. This nanopositioner 10 may be incorporated into data storage device 44 of Fig. 8. As shown, device 44 may include a storage medium 46 formed by a thin polymer layer supported by a substrate 48, e.g., formed of silicon. An array of probes 50 is mounted on a common frame 52. A large number of probes, such as 1024 or even more, may be used, or only just one probe. Each probe 50 comprises terminals which are electrically connected to a control and information processing unit 54 via electrically conductive lines. 10 In order to reduce the complexity of the wirings, the terminals may be connected via row-lines 56 and columnlines 58 and possibly via multiplexers (not shown) to the control and information processing unit 54. The control and information processing unit 54 is configured for 15 controlling the data storage system and for controlling a movement of the storage medium 46 (and substrate 48) relative to the frame 52 in x-y- and z- directions. movement may be effected by stage 16 of nanopositioner 10, which supports storage medium 2, e.g., via substrate 4. 20 (In Fig. 8, portions of nanopositioner other than stage 16 have been omitted for clarity.)

Indentations 60, 62, 64 are provided in storage medium 46, to represent logical information. For example, an indentation represents a logical "1", whereas the absence of the indentation mark may represent a logical "0". The indentations 60, 62, 64 are of a nanoscale diameter. They may, for example, have a diameter ranging from 10 to 50 nm. The formation of indentations 60, 62, 64 and also the detection or the erasure thereof may be accomplished by moving the probe(s) 50 into contact (either physical or non-physical) with respective indentation marks by use of

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nanopositioner 10 as controlled by processing unit 54.

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Embodiments of the invention having been described, a representative method of fabrication thereof is shown in Fig. 9.

At 70, fabrication commences with a conventional Silicon-on-insulator (SOI) substrate with, e.g., a 100um device layer thickness and lum thick buried oxide. At 72, trenches are etched (e.g., Deep RIE etch) to be used for buried copper coils. The trenches are thermally oxidized at 74, followed by deposition 76 of a seed layer for copper electroplating. The trenches are then filled 78 with electroplated copper, followed by planarization 80 of the upper surface, e.g., by chemical-mechanical polish (CMP).

enhanced chemical-vapor-deposition (PECVD), and patterned using a wet etch. The backside of the device is etched 84 (e.g., Deep RIE etch) to define the thickness and to expose the buried oxide layer. The exposed buried oxide layer is etched 86, e.g., using a wet etch, while applying a photoresist to protect the (opposite) front side of the device. A seed layer for copper electroplating is deposited to the front side at 88, followed by electroplating 90 the upper coils 30 using removable photoresist mold, followed by etching seed layer from the remainder of the front side. The device is etched 92 (e.g., Deep RIE etch with oxide and Cu as masks) to release flexures 18 from the combination actuator paddle 26 and coils 28, 30.

In summary, as discussed hereinabove, embodiments of actuator 12 provide for collocated and independently controllable in- and out-of-plane (e.g., X- and Z- axes) electromagnetic actuator forces enabled by two independent

coils 28, 30 having shifted phases relative to a magnet structure 15. Parasitic moments may be compensated and actuation forces optimized by controlling the geometry of the coils 28, 30. The coils may be fabricated as a double coil stack using as few as two metal layers separated by an insulator such as silicon dioxide.

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Additional embodiments use the actuator 12 to provide a 6-Axis Electromagnetic nanopositioner 10, capable of relatively high-frequency operation, e.g., bandwidth of about 150Hz to 1kHz in some embodiments, and about 500Hz to about 1kHz in others. These embodiments also provide a range of (stage) motion within a range of about 1 to 30 microns in some embodiments, and about 5 to 15 microns in others, enabled by electromagnetic actuation. This stage may be located with nanometer precision, such as within a range of about 5 to about 100 nanometers in some embodiments, and a range of about 5 to 15 in others. embodiments provide a tightly constrained design: e.g., nominally one-to-one input to DOF actuation, so that six input commands (e.g., two independently actuatable coil layers at each of three actuators) generate the same number of (six) output motions.

These embodiments also provide integration of microfabricated (e.g., micromachined) single-crystal semiconductor (e.g., silicon) flexures 18 and microfabricated (e.g., electroplated) coils. The coil leads 34 are integrated with the flexures 18, and the flexures are configurable to nominally eliminate out-of-plane thermal error motions.

The combination coils/paddle/compliant mechanism may be integrally fabricated using the same microfabrication processes. These processes also enable the double coil

stack 13 to be produced using only two metal layers
separated by an electrical insulator such as silicon
dioxide. Moreover, fabrication does not require the use of
permanent polymer and/or organic structures for
planarization, stacking, or electrical vias, thus
simplifying fabrication, saving weight, and enabling hightemperature operation. The microfabrication is thus
relatively simple, while enabling relatively thick copper
coils to be electroplated on bulk-micromachined singlecrystal-silicon flexures.

It should be understood that any of the features described with respect to one of the embodiments described herein may be used with any other of the embodiments described herein without departing from the spirit and scope of the present invention.

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Moreover, although embodiments have been shown and described having particular numbers of coils/coil sets, it should be recognized than substantially any number of coils/coil sets may be used without departing from the scope of the present invention.

In the preceding specification, the invention has been described with reference to specific exemplary embodiments thereof. It will be evident that various modifications and changes may be made thereunto without departing from the broader spirit and scope of the invention as set forth in the claims that follow. The specification and drawings are accordingly to be regarded in an illustrative rather than restrictive sense.

Having thus described the invention, what is claimed 30 is:

CLAIMS

1. An electromagnetically actuated microfabricated nanopositioner comprising:

- (a) a microfabricated compliant mechanism including:
 - a stage;
 - a support;
- a plurality of flexures coupled to said stage and to said support;
- a plurality of beams each coupled to at least one of said plurality of flexures; and

said beams sized and shaped wherein displacement thereof generates a displacement of said stage relative to said support;

said compliant mechanism being substantially planar to define in-plane directions substantially parallel thereto; and

(b) a plurality of actuators respectively coupled to said plurality of beams, each of said actuators including:

at least one first coil in the form of a microfabricated, electrically conductive first layer substantially parallel to said compliant mechanism;

at least one second coil in the form of a microfabricated electrically conductive second layer superposed with said first coil to form a coil stack; and

a magnet array disposed in magnetic communication with said coil stack;

said first and second coils being selectively, electrically actuatable to generate relative movement between said coil stack and said magnet array both inplane and out-of-plane;

(c) wherein said stage is configured for controlled movement with 6 degrees of freedom.

- 2. The nanopositioner of claim 1, wherein said compliant mechanism and said first and second coils are micro-lithographic.
- 3. A MEMS actuator comprising:

at least one first coil in the form of a microfabricated, electrically conductive first layer;

at least one second coil in the form of a microfabricated electrically conductive second layer, said second coil being superposed with said first coil to form a coil stack;

said layers being substantially planar to define in-plane directions parallel thereto; and

a magnet array superposed, in magnetic communication, with said coil stack; said first and second coils being selectively, electrically actuatable to generate relative movement

between said coil stack and said magnet array both in-plane and out-of-plane.

- 4. The actuator of claim 3, wherein said magnet array is immovably coupled to a ground, to form a moving-coil actuator.
- 5. The actuator of claim 3, wherein the coils are sized and shaped to compensate for any parasitic moments.
- 6. The actuator of claim 3, comprising only two microfabricated metal layers.

- 7. A MEMS nanopositioner comprising:
 - (a) a plurality of the actuators of claim 3;
 - (b) a microfabricated compliant mechanism including:
 - a stage;
 - a support;
 - a plurality of flexures coupled to said stage and to said support;
 - a plurality of beams each coupled to at least one of said plurality of flexures;

said beams sized and shaped wherein displacement thereof generates a displacement of said stage relative to said support;

said compliant mechanism being substantially
planar extending in-plane with said coils; and

said plurality of actuators respectively coupled to said plurality of beams; and

- (c) wherein said stage is configured for controlled movement with 6 degrees of freedom.
- 8. The nanopositioner of claim 7, wherein said compliant mechanism and said coil stacks of said actuators are microlithographic.
- 9. The nanopositioner of claim 8, wherein said coil stacks of said plurality of actuators are respectively coupled to said plurality of beams, to form moving-coil actuators.
- 10. The nanopositioner of claim 7, configured for actuation at a frequency within a range of:
 - at least about 150Hz; and

up to about 1kHz.

11. The nanopositioner of claim 10, configured for actuation at a frequency within a range of:

from about 500Hz;

to about 1kHz.

12. The nanopositioner of claim 7, wherein said stage is configured for motion within a range of:

about 1 micron;

to about 30 microns.

13. The nanopositioner of claim 12, wherein said stage is configured for motion within a range of:

about 5 microns;

to about 15 microns.

14. The nanopositioner of claim 12, wherein said stage is configured for being precisely located with a range of precision within a range of:

about 5 nm;

to about 100 nm.

15. The nanopositioner of claim 14, wherein said stage is configured for being precisely located with a range of precision within a range of:

about 5 nm;

to about 15 nm.

16. The nanopositioner of claim 7, having a one-to-one correspondence of inputs to said degrees of freedom.

17. The nanopositioner of claim 7, wherein said compliant mechanism is microfabricated integrally with said coils.

- 18. The nanopositioner of claim 17, wherein said compliant mechanism comprises a single-crystal semiconductor.
- 19. The nanopositioner of claim 18, leads for said coils are integrally disposed on said flexures.
- 20. The nanopositioner of claim 7, wherein said flexures are configured to substantially eliminate out-of-plane thermal error motions.
- 21. The nanopositioner of claim 7, being free from the use of polymeric and organic materials.
- 22. The nanopositioner of claim 7, disposed within a nano-electro machining system.
- 23. The nanopositioner of claim 7, disposed within a nanomanipulator.
- 24. The nanopositioner of claim 23, wherein said nanomanipulator comprises a cellular micro-injection workstation.
- 25. The nanopositioner of claim 7, disposed within a data storage system.
- 26. A method of effecting a MEMS actuation, said method comprising:
- (a) providing at least one actuator having:

at least one first coil in the form of a microfabricated, electrically conductive first layer;

at least one second coil in the form of a microfabricated electrically conductive second layer, said second coil being superposed with said first coil to form a coil stack;

said layers being substantially planar to define in-plane directions parallel thereto; and

a magnet array superposed, in magnetic communication, with said coil stack; and

- (b) selectively, electrically actuating the first and second coils to generate relative movement between the coil stack and the magnet array both in-plane and out-of-plane.
- 27. The method of claim 26, comprising:
- (c) providing a microfabricated compliant mechanism including:
 - a stage;
 - a support;
 - a plurality of flexures coupled to said stage and to said support;
 - a plurality of beams each coupled to at least one of said plurality of flexures;

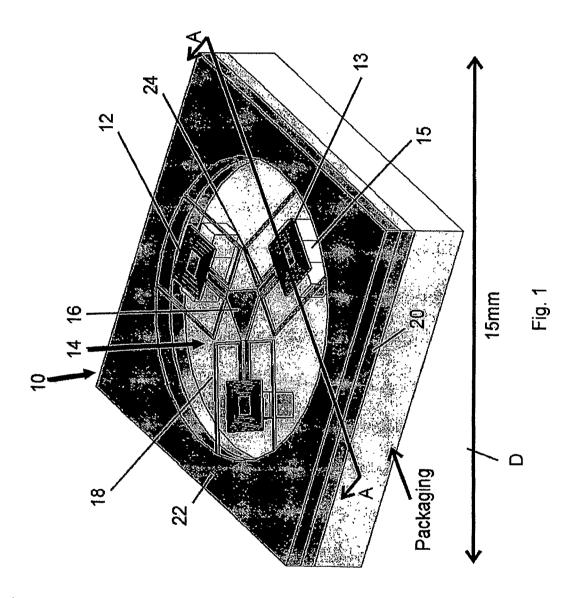
said beams sized and shaped wherein displacement thereof generates a displacement of said stage relative to said support;

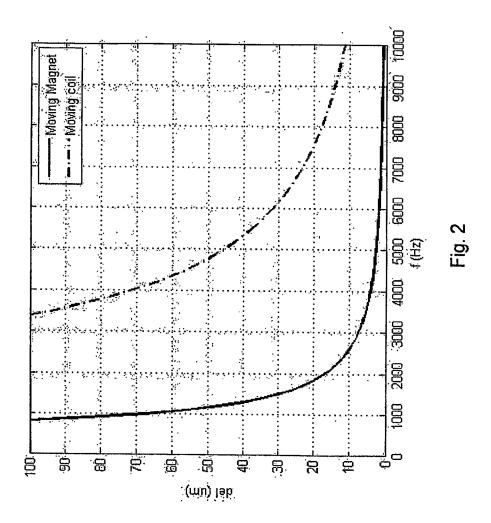
said compliant mechanism being substantially planar, extending in-plane; and

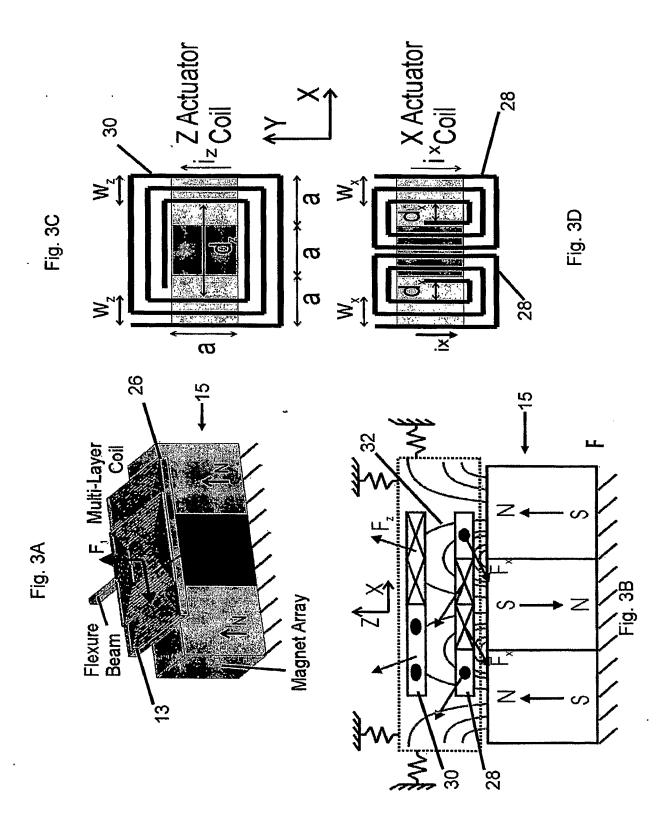
- a plurality of said actuators respectively coupled to said plurality of beams; and
- (d) selectively, electrically actuating the first and second coils of each of said actuators to generate

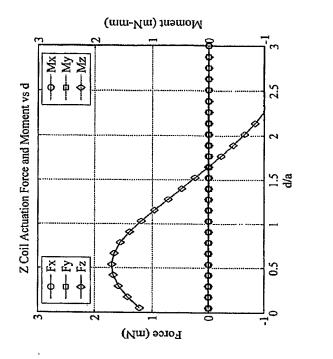
controlled movement of said stage with 6 degrees of freedom.

28. The actuator of claim 3, comprising a dielectric layer disposed between said first layer and said second layer.

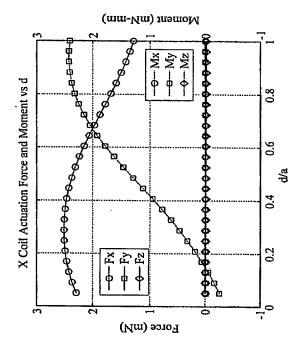




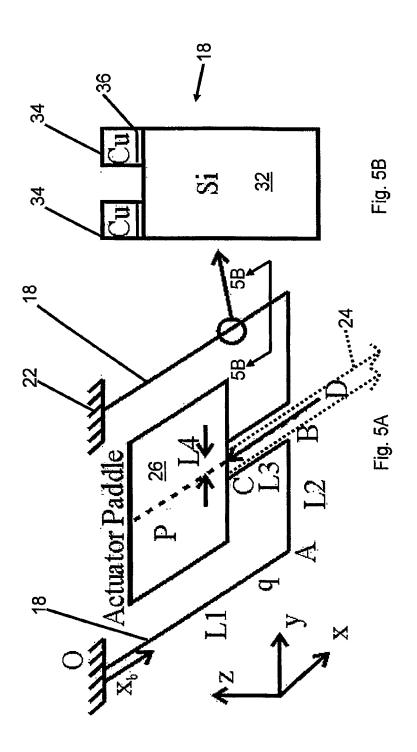








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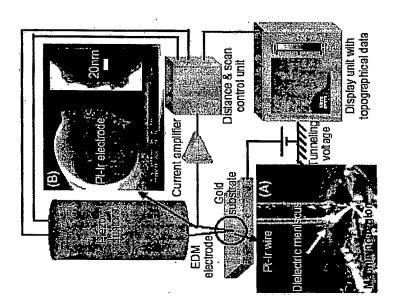


Fig. 6

